

Simulation of microtearing turbulence in NSTX and scaling with collisionality

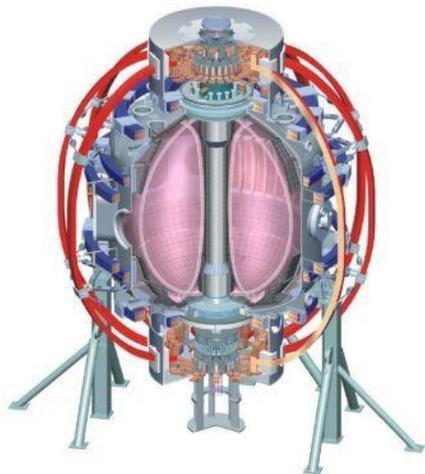
Walter Guttenfelder¹, J. Candy², S.M. Kaye¹,
W.M. Nevins³, E. Wang³, R.E. Bell¹, B.P. LeBlanc¹,
G.W. Hammett¹, D.R. Mikkelsen¹, H. Yuh⁴

¹PPPL

²General Atomics

³LLNL

⁴Nova Photonics Inc.



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Outline of talk / Work done (follows TTF plenary talk)

- Experimental motivation: favourable $\Omega_i \tau_{E,th} \sim v_*^{-0.95}$ dependence in NSTX
 - Cause of anomalous χ_e in high- β discharges unknown, scaling to future devices uncertain
 - Microtearing modes unstable in high v_* discharges ($r/a \approx 0.5-0.8$)
 - Linear stability scaling $\gamma_{lin} \sim v_e$ qualitatively consistent with experimental trend → motivates non-linear simulations using realistic experimental parameters
- First non-linear gyrokinetic microtearing simulations for NSTX (PRL, 2011)
 - New and unique physics
 - Simulations require relatively fine radial grid to resolve resonant current layers ($\Delta_j \sim 0.3\rho_s$)
 - Significant transport ($\chi_{e,sim} \approx \chi_{e,exp} \approx 5\text{m}^2/\text{s}$), dominated ($\sim 98\%$) by magnetic flutter ($\delta B_r/B \sim 0.15\%$)
 - Perturbed field lines are globally stochastic ($w_{island} > \delta r_{rat}$), test particle stochastic transport model ($\chi_{st} \approx v_{Te} \cdot D_M$) agrees to within 25% of simulations
 - Transport scaling relevant to experiment
 - Predicted $\chi_{e,sim}/\chi_{GB} \sim v_{*e}^{1.1}$ similar to experimental scaling
 - “Stiff” with ∇T_e , instability threshold important (apparent non-linear upshift)
 - Suppressible by experimental levels of $E \times B$ shear
 - Measurement opportunities
 - BES ($k_\theta \rho_s < 1$), high-k scattering (δn , $k_r \gg k_\theta$), polarimetry (δB_r strong, broad & ballooning)

Additional work that could strengthen conclusions

- Summarize newer, more comprehensive linear scans
 - Generally, γ maximum around $Z_{\text{eff}} \cdot v_{\text{ei}} / \omega_{*e} \sim 1-5$, complicates simple $\gamma_{\text{lin}} \sim v_{\text{ei}}$ interpretation
 - Finite thresholds in β_e , a/L_{Te} , also γ maximum around $s/q \sim 1.5$
 - We can contrast scaling with ETG, especially differences in Z_{eff} , s/q
 - Highlight experimental range of $Z_{\text{eff}} \cdot v_{\text{ei}} / \omega_{*e}$, β_e , s/q etc... for v_* , β , I_p , B_t scans
- Clarify influence of Δx in nonlinear v_{ei} and ∇T_e scaling
 - Additional simulations at higher v_{ei} to identify local maximum predicted linearly
 - Limited repeat of v_{ei} scan at higher resolution (& with γ_E) – does $\chi_{e,\text{sim}} / \chi_{\text{GB}} \sim v_{*e}^{1.1}$ hold?
 - Apparent non-linear $(\nabla T_e)_{\text{crit}}$ upshift – possibly a consequence of sub-optimal resolution?
- Clarify influence of $Z_{\text{eff}} > 1$ in nonlinear sims
 - Increasing Z_{eff} tends to destabilize microtearing and shifts γ maximum via $Z_{\text{eff}} \cdot v_{\text{ei}}$
 - Possibly OK to run simulations with reduced ion model (adiabatic, or one ion with $n_i/n_e = Z_{\text{eff}}$)
- Have also tried numerous simulations at other locations ($r/a=0.5, 0.65, 0.7$), so far without much success